

VM+SD 11th Annual International VISUAL COMPETITION

the art of style

SONY STYLE



2003 BEST OF SHOW
Sony Style
New York

Design: Sony Style in-house creative team, New York
Photography: Richard Caden, New York

2003 Competition coverage is in the
August 2003 issue of *VM+SD*, pages 28-35.



ENTRY DEADLINE:
March 31, 2004

Questions?

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the *VM+SD* 11th Annual International Visual Competition, celebrating
great achievements in visual merchandising, storewide promotions and
window displays. **Remember to photograph your windows and projects.**